SLOVENSKI STANDARD
oSIST prEN IEC 63516:2025

01-september-2025

Metoda preskušanja obstojnosti pri fiksnem upogibanju za zvijava optoelektrična vezja

Fixed folding durability test method for flexible opto-electric circuit boards

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Ta slovenski standard je istoveten z: **prEN IEC 63516:2025**

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ICS:

31.180	Tiskana vezja (TIV) in tiskane plošče	Printed circuits and boards

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2003-01.Slovenski inštitut za standardizacijo. Razmnoževanje celote ali delov tega standarda ni dovoljeno.

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91/2046/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER:	
IEC 63516 ED1	
DATE OF CIRCULATION:	CLOSING DATE FOR VOTING:
2025-07-11	**2025-10-03**
SUPERSEDES DOCUMENTS:	
91/1981/CD, 91/2010/CC	

IEC TC 91 : ELECTRONICS ASSEMBLY TECHNOLOGY	
SECRETARIAT: Japan	SECRETARY: Mr Osamu IKEDA
OF INTEREST TO THE FOLLOWING COMMITTEES:	HORIZONTAL FUNCTION(S):
ASPECTS CONCERNED:	
☒ SUBMITTED FOR CENELEC PARALLEL VOTING **Attention IEC-CENELEC parallel voting** The attention of IEC National Committees, members of CENELEC, is drawn to the fact that this Committee Draft for Vote (CDV) is submitted for parallel voting. The CENELEC members are invited to vote through the CENELEC online voting system.	☐ NOT SUBMITTED FOR CENELEC PARALLEL VOTING

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TITLE:

Fixed folding durability test method for flexible opto-electric circuit boards

PROPOSED STABILITY DATE: 2030

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